

Title (en)
METHOD FOR DETECTING ATYPICAL ELECTRONIC COMPONENTS

Title (de)
VERFAHREN ZUM DETEKTIEREN VON ATYPISCHEN ELEKTRONISCHEN KOMPONENTEN

Title (fr)
PROCÉDÉ DE DÉTECTION DE COMPOSANTS ÉLECTRONIQUES ATYPIQUES

Publication
EP 2391929 A1 20111207 (FR)

Application
EP 10702298 A 20100202

Priority
• EP 2010051235 W 20100202
• FR 0900424 A 20090202

Abstract (en)
[origin: WO2010086456A1] The invention relates to a method for detecting atypical electronic components for the quality control of n electronic components at the end of the manufacturing process, said components being subjected to a number p of unit tests providing digital data, said set of n components including electronic components having a response to each of the p unit tests that lies within predetermined limits particular to each of the p tests, wherein the method comprises using the multi-dimensional information of the p dimension responses of said n electronic components. The method uses a generalised principal component analysis for detecting atypical parts in the semiconductor field, or in the fields including modules assembled using electronic components (e.g. an ABS module, a smart card, etc.). The aim of the method is to get close to "zero defect", wherein no part is detected to be substandard by the client.

IPC 8 full level
G05B 23/02 (2006.01)

CPC (source: EP US)
G01R 31/2894 (2013.01 - EP US)

Citation (search report)
See references of WO 2010086456A1

Citation (examination)
US 2008189575 A1 20080807 - MIGUELANEZ EMILIO [GB], et al

Designated contracting state (EPC)
AT BE BG CH CY CZ DE DK EE ES FI FR GB GR HR HU IE IS IT LI LT LU LV MC MK MT NL NO PL PT RO SE SI SK SM TR

DOCDB simple family (publication)
WO 2010086456 A1 20100805; CN 102388347 A 20120321; EP 2391929 A1 20111207; FR 2941802 A1 20100806; FR 2941802 B1 20160916; JP 2012516994 A 20120726; SG 174352 A1 20111028; US 2012053877 A1 20120301

DOCDB simple family (application)
EP 2010051235 W 20100202; CN 201080016331 A 20100202; EP 10702298 A 20100202; FR 0900424 A 20090202; JP 2011546872 A 20100202; SG 2011065661 A 20100202; US 201013146924 A 20100202